

# The NO $\nu$ A electron neutrino appearance analysis



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## INTRODUCTION



## **EVENT SELECTION**

• **Fine-grained** detector: radiation length 38cm (10 cell widths)



#### $\nu_{\mu}$ charged current • Easy to reject muon

track

- $\nu_e$  signal
- Electron shower

#### Neutral current

•  $\pi^0 \rightarrow \gamma \gamma$  fakes electron shower

0.8

• Conv. length 50cm



— NC Estimate

300

#### Michel method

•  $N_{NC}^{decomp} = \frac{N_{MRCC}^{data}}{N_{Sim}} N_{NC}^{sim}$ 

- Count Michel electron candidates in  $\nu_e$ -selected events
- Scale MC templates for  $\nu_{\mu}$  CC, NC, beam  $\nu_e$  to match

#### RVP

#### LEM

- Compare to large MC library
- Match via electrostatic analogue
- Use properties of best-matched events



 $- v_{\mu}$  CC bkg



- Is  $\nu_3$  heavier (NH) or lighter (IH) than  $\nu_1/\nu_2$ ?
- Alters sign of matter effects
- Important for interpretation of  $0\nu\beta\beta$  expts.
- Large matter effects ( $\pm 30\%$ ) from uniquely long baseline
- 95% C.L. determination for 1/3 of  $\delta_{CP}$  values • Increases to 99% C.L. for doubled exposure



Normal Hierarchy (NH) Inverted Hierarchy (IH)

- Is  $\nu_3$  more  $\nu_{\mu}$  ( $\theta_{23} > 45^{\circ}$ ) or more  $\nu_{\tau}$  ( $\theta_{23} < 45^{\circ}$ )?
- $\nu_e$  appearance ~  $\sin^2 \theta_{23}$ , measures  $\theta_{23}$
- 95% C.L. determination for all  $\delta_{CP}$
- $3\sigma 4.5\sigma$  for doubled exposure

### ASSUMPTIONS

- 3 years  $\nu$  + 3 years  $\bar{\nu}$  (2 × 18 × 10<sup>20</sup> POT) •  $\sin^2 2\theta_{13} = 0.95$
- $\Delta m_{32}^2 = 2.40 \times 10^{-3} \text{ eV}^2$
- $\sin^2 2\theta_{23} = 1.00$  or 0.95
- Assuming high efficiency cosmic ray rejection (G. Davies, T. Xin, J. Bian poster)
- Joint fit with NO $\nu$ A  $\nu_{\mu}$  analysis (K. Bays poster) and reactor constraints

mass hierarchy/CP phase space, with the  $\theta_{23}$ octant mostly uncorrelated



• Could reject NH, upper octant at  $>5\sigma$  and favour correct hierarchy/octant at 95% C.L.